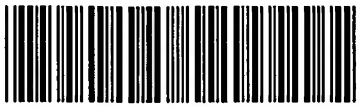


<b>Search Notes</b>  	<b>Application/Control No.</b>  10634616	<b>Applicant(s)/Patent Under Reexamination</b>  FRANZ ET AL.
	<b>Examiner</b>  Hernandez, Josiah	<b>Art Unit</b>  2112

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
704	8	01/17/2008	JH

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Search EAST, NPL through the ACM and IEEE database: see search print out	01/22/2007	JH
consulted with search mentor Talivaldis Smits	01/22/2007	JH
Fast and Focus search: see search print out	01/22/2007	JH

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>